

<b>Notice of References Cited</b>	Application/Control No. 10/534,347	Applicant(s)/Patent Under Reexamination ANDER ET AL.
	Examiner Michael Bernshteyn	Art Unit 1713

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,713,641	03-2004	Weaver et al.	552/254
	B	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP0735122A2	10-1996	Japan	Inagi, Toshio et al.	C09J 133/06
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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